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Electronic sputtering of solid N₂ by swift ions

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Abstract

Most sputtering yield measurements for solid N₂ are reported for stopping powers lower than 10⁻¹³ eV cm²/molecule. We measured the sputtering yield for solid N₂ at stopping powers, in the electronic regime, above 10⁻¹² eV cm²/molecule, extending the range of such measurements by more than an order of magnitude, using a 33 MeV ⁵⁸Ni⁹⁺ swift heavy ions beam. The evolution of the thin N₂ ice films was monitored in-situ by mid-infrared spectroscopy (FTIR) during irradiation. As N₂ is only weakly infrared active, and can be hardly monitored directly via an infrared absorption mode in such experiments, we use the Fabry-Perot interference fringes of the ice film to evaluate, via an optical model, the erosion of the N₂ film as a function of ion fluence. A sputtering model including several sputtering crater shapes is developed and tested against experimental data. We derive the sputtering yield for a semi-infinite N₂ ice film and its dependence with the ice thickness for thin film conditions, monitoring the N₂ ice sputtering depth. We combine the results with previous measurements at lower stopping powers to derive the electronic sputtering of solid N₂ over a large stopping power range.

Keywords: Electronic sputtering, Radiation chemistry, Heavy ions, Solid N₂, Sputtering crater

1. Introduction

The impact of fast ions on insulators such as, in the present case, frozen gases, results in an ionisation track. The high energy primary ion and its induced secondary electrons create repulsive electronic excited states on timescale much shorter than that of changes in the ice structures. A very large part of this energy is converted to the motion of nuclei, and in a time scale of the order of tenths to tens of nanoseconds, a small hot volume appears, often referred as "thermal spike" [1, 2]. This thermal spike thermalises and, near the surface, sudden sublimation occurs. Many laboratory studies have been performed on ice sputtering, in particular in the 80° and 90° using projectiles with low stopping power. Since a decade, large facilities open the possibility to

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10 access to projectiles with high stopping power. Such studies provide realistic numbers to deter-
mine the effects of heavy cosmic rays (CR) in the dense clouds phases of the Galaxy and in the
outer part of the solar system that are essential to astrophysical models. These laboratory exper-
iments allow to better constraint sputtering yields (number of constituent lost by the ice per ion),
but also radiolysis and chemical composition of the sputtered material. The thickness dependence
15 of the sputtering yield is a critical parameter, as thin ices films with respect to the probed volume
may be encountered in astrophysical media. For many ices (H_2O , CO , CO_2 , O_2 [3, 4, 5, 6, 7])
and for the stopping powers relevant to CR ($Z=1$ to 37, $E=0.1\text{MeV/u}$ to 10 GeV/u) the sputtering
yield for an ice of infinite thickness can be inferred. The sputtering yield is generally predicted
to scale proportionally to the square of the stopping power for many low temperature molecular
20 solid. Measurements of sputtering yields may be achieved by different methods, including mi-
crobalance, by measurements of the energy spectra of backscattered heavy projectiles (RBS) or
backscattered electrons. With the advance of infrared spectrometers, and thanks to the high sput-
tering yield at high stopping power, direct measurements by IR absorption during the irradiation
becomes accessible, and such spectrometers became routinely used in many facilities. From an
25 experimental point of view, N_2 is a particular case with respect to most other ices, as it possesses
a very low infrared activity (integrated band strength of $A \approx 1.3 - 1.8 \times 10^{-22}\text{cm/N}_2$, [8, 9],
about four orders of magnitude lower than typical molecules infrared-active modes, a band lo-
cated at about 2300 cm^{-1}). As a consequence it is difficult to employ the IR absorption method.
In the literature, probably due to these experimental challenges, the sputtering yield of N_2 shows
30 marked variations, and debates occurred [10] in the 90' concerning a particular behaviour of the
 N_2 ice sputtering yield as a function of the stopping power for low stopping power projectiles. A
transition from a linear to quadratic evolution was hypothesised but uncertainties remains on its
transition range. In this work we measured at the GANIL facility the sputtering yield for solid
 N_2 ice impacted by high stopping power projectiles. The thickness evolution was monitored
35 during irradiation using the ice thin film Fabry-Perot interference fringes. The experiments, and
the optical model used to derive ice thickness, are presented in a first section. In a second part
we present the model used to reproduce the behaviour of the sputtering yield at low thickness.
Finally, we present an overview of our measurements together with those from the literature and
discuss about the particularity of N_2 ice.

40 2. Experiments

Swift ion irradiation experiments were performed at the heavy-ion accelerator Grand Accé-
lérateur National d'Ions Lourds (GANIL). $^{58}\text{Ni}^{9+}$ projectiles were accelerated at 33 MeV on
the IRRSUD beam line in May 2019. This beam was sent to an ultra high vacuum chamber, the
IGLIAS (Irradiation de GLaces d'Intérêt ASTrophysique) facility [11], operating in the 10^{-9} mbar
45 range for the considered experiments. The N_2 molecular ice films were condensed on an infrared
transmitting ZnSe substrate window cryocooled at 9 K. The ice films are produced by placing the
cold window substrate in front of a deposition line where gaseous $^{15}\text{N}_2$ is injected. The vacuum
during the experiments is dominated by infrared inactive species such as H_2 , not sticking to the
surface during the irradiation, and residual N_2 molecules as residual of the ice film injection
50 sequence or from the electronic sputtering itself. We do not observe on the recorded infrared
spectra any signature of H_2O ice accumulation, showing that its partial pressure is much lower.
In one experiment, a very small pollution of CO_2 , with a negligible column density with respect
to the ice film one, is observed in the infrared, converted to CO during the beam irradiation,
and disappear during the course of the irradiation. At the ion fluxes used of $10^9\text{ ion/cm}^{-2}/\text{s}$, the

55 potential redeposition is not a strong concern on the presented results, and would contribute to slightly increase the estimated sputtering yield is the analysis presented hereafter. Two ice films were irradiated, with initial thickness of 0.3 and 1 micron, respectively. At such thicknesses, the ion beam passes through the film with an almost constant energy deposition.

At the ion energy used here, the stopping power is dominated by the electronic regime. SRIM 60 calculations yield a value of $Se \approx 1697 \times 10^{-15} \text{eV cm}^2 / ^{15}\text{N}_2 \text{ molecule}$. In the following, we refer to "electronic stopping power" for brevity. A Bruker Vertex 70v FTIR spectrometer with a spectral resolution of 1 cm^{-1} was used. The evolution of the infrared spectra was recorded at several fluences. The infrared transmittance spectra were recorded at 12° of incidence (a correction factor of 0.978 is therefore applied to determine the normal column densities).

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3. Analysis

3.1. Optical model

As solid N_2 (the same is true for $^{15}\text{N}_2$) infrared activity is very low (integrated band strength of $A \approx 1.3 - 1.8 \times 10^{-22} \text{cm}/\text{N}_2$, [8, 9]), we recorded the amount of nitrogen ice deposited 70 through measurements of interference fringes that are directly related to the thickness of the thin ice film. We used thicknesses of about one micron and a third of a micron, respectively. Such thicknesses are large enough to provide measurable interference fringes and thin enough to reach the complete sputtering of the film at the end of the experiment. Fig.1 and Fig.2 upper panels show the raw transmittance spectra in the $5500\text{-}1000 \text{ cm}^{-1}$ range measured as function of ion 75 fluence. These spectra did not exhibit new strong bands upon irradiation. The production of new infrared active species during the irradiation is dominated by the azide radical ($^{15}\text{N}_3$), observed in the thick film experiment, with a doublet around 1603 and 1598 cm^{-1} (see, e.g. [12] for this isotopomer assignments). The column density of the azide radical is estimated from the [13] integrated band strength of $A = 7.2 \times 10^{-20} \text{cm}/^{15}\text{N}_3$, representing less than about 5% of the ice 80 film composition. A few absorption bands corresponding to low amounts of CO and CO_2 are observed. They originate from a slight pollution during the several hours of experiments, and are present in particular in the thick film experiment, which was the first one sequentially. An optical model was fitted to the data to extract the film thicknesses. The simulated model is calculated using the rigorous expression for the transmission of a thin absorbing film, of thickness d , on a 85 thick transparent substrate, as presented in, e.g., [14]

$$T = \frac{16ns^2}{(n+1)^3(n+s^2) - 2(n^2-1)(n^2-s^2)\cos(\phi) + (n-1)^3(n-s^2)} \quad (1)$$

In this expression, $\phi = 4\pi nd/\lambda$. The wavelength (λ) dependent refractive index s of ZnSe, used as substrate in the experiment, is taken from [15], and is shown in the upper panel of Fig.7. A refractive index of solid N_2 of $n=1.22$ is adopted, as measured by Satorre et al.[16, 17]. A least squares fit procedure is used to fit the model to the measurements and retrieve the 90 thickness values. Due to the lack of thermalisation of the experience hall, progressive although limited, variations on the gain of the overall signal (of less than about two percents) are observed during the measurements. This slowly varying instrumental effect is compensated for in the minimisation by applying an equivalent global gain correction to the spectra. The gain variations applied in the time response is shown in the lower panels of Fig.7. The best fitted model spectra

95 calculated during the minimization are shown in the lower panel of Fig.1 and Fig.2.
 The column density of $^{15}\text{N}_2$ ice can be estimated from

$$N_{^{15}\text{N}_2} = N_A \times \rho \times d / M_{^{15}\text{N}_2} \quad (2)$$

where N_A , ρ , d and $M_{^{15}\text{N}_2}$ are the Avogadro number, the $^{15}\text{N}_2$ ice density, the film thickness and the molar mass of $^{15}\text{N}_2$, respectively. The $^{15}\text{N}_2$ ice density adopted is $\rho = 0.94 \times 30/28 \text{ g/cm}^3$ (0.94 g/cm^3 corresponds to the $^{14}\text{N}_2$ measurement from [16, 17]). Note that ion irradiations of ice
 100 films can induce an amorphous compaction of ice structures when starting from amorphous and porous ice films, that may affect the density and thus column density estimates. Compaction, given the cross-sections for other ices at such dE/dx , occurs within fluences typical of a few 10^{11} cm^{-2} . With the fluences presented in this study we are in the present experiments analysing a compact N_2 ice sputtering phase. The very first fluence points could be affected by a compaction phase change, but we do not observe any evidence of an abrupt change at the beginning
 105 of the irradiation that would underline a significant compaction. As shown in [16, 17], N_2 ice deposits do not show significant changes of refractive index nor density with temperature until sublimation under our experimental conditions. We thus expect the density to be close to the one adopted from their measurements. If another density is adopted, therefore the extracted yields must be adjusted proportionally to the inverse of the newly adopted value.
 110

3.2. Sputtering model

The column density evolution of the ice molecules submitted to ion irradiation can be described, for a semi infinite (thick) film, by

$$dN/dF = -Y_s - \sigma N \quad (3)$$

115 With Y_s the sputtering yield and σ the radiolysis destruction rate. The observed thickness evolution is dominated by sputtering (over radiolysis with small amounts of $^{15}\text{N}_3$ discussed above). As a result, $\sigma N \ll Y_s$ and the column density decreases linearly with the fluence, with a slope giving the yield of sputtered molecules per ion. As shown in Fig.6, the evolution of the column densities departs from this model for column densities below about $6 \times 10^{17} \text{ cm}^{-2}$ in both
 120 experiments. This change occurs because the maximum depth of sputtering by individual ions for a semi infinite ice film, hereafter called the probe depth, is then larger than the film thickness, inducing a decrease in the effective yield. Considering a direct impact model where all the molecules within a sputtering effective volume are removed from the surface [3], the evolution of the sputtering yield, as a function of ion fluence (F) can be inferred. The decay of the sputtering
 125 efficiency, when reaching thin film thicknesses lower than the probe depth of ions can be set by

$$dN/dF = -Y_s^\infty \left(1 - e^{-\frac{N}{N_D}} \right) \quad (4)$$

where Y_s^∞ is the semi-infinite ice film sputtering yield, and N_D is the ice column density corresponding to the sputtering probe depth by an individual incident ion. This parametrisation allows a single and simple parameter estimate of the sputtering depth. Note that for $N \gg N_D$ $dN/dF \rightarrow -Y_s^\infty$ and $\rightarrow 0$ for $N \ll N_D$. The solution to this equation comes down to

$$N(F) = N_D \times \ln \left(e^{-\frac{Y_s^\infty F}{N_D} + \ln \left(e^{\frac{N_0}{N_D}} - 1 \right)} + 1 \right) \quad (5)$$

130 where N_0 is the initial column density. The crater resulting from sputtering has been studied experimentally [18, 19, 20, 21, 22, 23] for different materials. Detailed calculations were often conducted using molecular dynamic simulations [24, 25, 26].

In [3], craters formed by ion impact were phenomenologically described with an oversimplified cylinder shape (i.e a cross-section approach). In this work, we simulate the sputtering with a simple model generating ions with a random impact position in the x-y perpendicular to the beam propagation, irradiating a slab of solid N_2 molecules. Each ion sputters a volume of matter, producing a 'crater'. The model follows the evolution of the column density, as would be measured by infrared spectroscopy. We adopted two 'crater' shapes: a cylinder and a Gaussian shape (shown in Fig. 3). The former was first adopted as it allows defining easily an aspect ratio, which is the ratio of the sputtered volume typical dimensions. One dimension is taken along the ion propagation axis, the sputtering depth d , i.e. the height of the cylinder, and the other is the diameter of the cylinder (2 times its radius r_c), leading to an aspect ratio, $AR = d/2r_c$. The Gaussian profile is probably a better approximation for the shape of a crater. The 2D Gaussian amplitude is set to the same depth d . As both profiles are parametrised with a common and fixed depth d , they must be normalised to maintain the same sputtering volume for comparison. To maintain the same sputtered volume, the corresponding Gaussian width, defined by the standard deviation σ is related to the cylinder radius by $\sigma = r_c/\sqrt{2}$. We generated several sets of models, each one repeated with ten independent runs. All models have in common, an approximately $2000\text{ nm}\times 2000\text{ nm}$ slab, an initial thickness scaled to an equivalent column density of $N_0 = 2 \times 10^{18}\text{ cm}^{-2}$ (corresponding to one of the experiments performed), and a sputtering depth fixed to $N_D = 4 \times 10^{17}\text{ cm}^{-2}$, that is close to the observed change in column density with the fluence for both experiments. The sets differ in the explored crater's aspect ratios, varied from one to forty. Changing the aspect ratio and keeping fixed the sputtering depth changes and defines the semi infinite sputtering yield. The simulated parameters that varies are shown in the left column of Table 1. A zoom at different irradiation times are shown in Fig.4 for one of the 2D Gaussian models. The column density evolution comparison for the Gaussian and cylinder crater shapes is presented in Fig.5. The crater shape influences differently the evolution at low column densities. Once the column density evolution with fluence was simulated with the model, it

Table 1: Model simulations fitting summary

Model ^a		Cylinder ^b			Gaussian ^b		
Aspect Ratio	Y^∞	N_0 $\times 10^{18}\text{cm}^{-2}$	N_D $\times 10^{17}\text{cm}^{-2}$	Y^∞	N_0 $\times 10^{18}\text{cm}^{-2}$	N_D $\times 10^{17}\text{cm}^{-2}$	Y^∞
1	1.41×10^8	2.00 ± 0.02	6.71 ± 0.14	$1.56 \pm 0.18 \times 10^8$	2.00 ± 0.04	4.07 ± 0.62	$1.47 \pm 0.07 \times 10^8$
3	1.57×10^7	2.01 ± 0.01	7.12 ± 0.12	$1.79 \pm 0.07 \times 10^7$	2.00 ± 0.01	4.12 ± 0.27	$1.62 \pm 0.03 \times 10^7$
5	5.65×10^6	2.01 ± 0.01	6.93 ± 0.42	$6.40 \pm 0.02 \times 10^6$	2.00 ± 0.01	4.09 ± 0.23	$5.87 \pm 0.08 \times 10^6$
10	1.41×10^6	2.01 ± 0.01	6.87 ± 0.31	$1.60 \pm 0.03 \times 10^6$	2.00 ± 0.01	4.09 ± 0.20	$1.47 \pm 0.02 \times 10^6$
40	8.83×10^5	2.00 ± 0.01	6.98 ± 0.33	$1.02 \pm 0.04 \times 10^6$	2.00 ± 0.01	4.00 ± 0.16	$9.17 \pm 0.01 \times 10^5$

^a The initial column density is set to $N_D = 2 \times 10^{18}\text{ cm}^{-2}$, and the sputtering depth is fixed to $N_D = 4 \times 10^{17}\text{ cm}^{-2}$. error bars are 2 sigma standard deviations from the model fitting. ^b Fitted parameters.

was fitted with equation 5. The fitted parameters retrieved for the different fiducial models are

160 given in Table 1. These simulations show that the initial column density is retrieved efficiently for all models. The semi-infinite sputtering yields are reasonably well inferred in both models, with a slight overestimation in the cylinder model. A greater difference appears for the retrieved sputtering depth N_D . The cylinder shape approximation overestimates N_D by up to 75%. This can be expected when looking at Fig.5 showing simulations of the column density evolution for
 165 two models with the same parameters, differing only in the crater shape. The model with a cylinder shape crater deviates from the semi-infinite slope behaviour earlier than the Gaussian crater shape one. The Gaussian crater shape model, as seen in Table 1 fitted parameters, allows a better fitting procedure to infer the depth within about 10%. Equation 5 thus describes adequately the 2D Gaussian sputtering crater shape.

170 3.3. Sputtering yield and depth for N_2

We fitted equation 5 to the measured column density as function of projectile fluence in order to determine both the sputtering yield and the sputtering depth of the irradiated N_2 ice films. The column density evolution and the model fits based on equation 5 are shown in Fig.6, overlaid to the data as thick dashed red lines. The thin dashed red lines correspond to the expected evolution
 175 considering a sputtering yield independent of the thickness (i.e. kept with the semi infinite value). The result of the fit gives access to $Y_s^\infty = 8.0 \pm 1.2 \times 10^4$ sputtered N_2 /ion, and a depth of sputtering of $N_D = 3.9 \pm 1.8 \times 10^{17} \text{ cm}^{-2}$, corresponding to about 5.25×10^2 monolayers assuming the ice density given above. It is difficult to constrain the sputtering contribution mediated via the interface with the ZnSe substrate. However, for completeness, we calculated the expected
 180 sputtering yield from the ZnSe substrate from literature data to evaluate its potential influence. SRIM calculations yield, for the present study Ni ions, a stopping power value in the substrate of $\text{Se} \approx 3800 \times 10^{-15} \text{ eV cm}^2/\text{ZnSe}$. Pannu et al. [27] estimated the sputtering of ZnSe exposed to 100 MeV Ag ions to be of $300 \pm 30 \text{ Zn/ion}$. The stopping power of these Ag ions is about 1.87 times higher than the Ni ions used in our study. Assuming a quadratic dependence of the yield
 185 with the stopping power, we estimate a ZnSe sputtering yield of $\sim 86 \text{ Zn/ion}$, i.e. almost three orders of magnitude lower than the above measured $Y_s^\infty = 8.0 \pm 1.2 \times 10^4$ sputtered N_2 /ion. The expected diameter of the sputtering crater for ZnSe is therefore much smaller. Given this huge difference in sputtering efficiencies, we are most probably dominated in our measurements by the N_2 ice behaviour. Our measurement is reported together with measurements at lower stopping
 190 power from the literature [10, 28, 29, 30] in Fig.8. A summary of these literature values and the present work is given in Table 2. When reported as a function of the electronic stopping power, this sputtering yield is in better agreement with the quadratic behaviour extrapolation from the data of [30], [29] and [28]. Data from [10] alone appears significantly below the other sets of data. The data are fitted with a power law to describe the sputtering yield as a function of the
 195 stopping power. Considering this work and the literature data above, the yield can be described by

$$Y_s^\infty = 1.69_{-1.38}^{+7.54} \times 10^{-2} \times \text{Se}^{2.04 \pm 0.40} \quad (6)$$

with Se in units of $10^{-15} \text{ eV cm}^2/\text{molecule}$, reported in Fig.8. This new measurement further confirms that the solid N_2 yield has a quadratic dependence with stopping power, a dependence holding at the large dE/dx reported in this study. The evolution of N_2 is close to the CO sputtering
 200 yields and has a similar stopping power dependence. If N_2 is mixed with CO in the dense phases of interstellar molecular clouds, its sputtering should therefore proceed with a similar overall efficiency.

4. Conclusion

The column density evolution of low temperature solid N_2 films irradiated with swift heavy ions was determined with a new approach measuring the film interference fringes in the infrared spectra, and supported by an optical modelling. A model simulating the swift ions sputtered ice volume with a cylinder or a two dimensional Gaussian is proposed. The amplitude of the cylinder or Gaussian represents the sputtered species maximum depth origin induced by individual ions. We showed that the transition from a semi infinite medium to thin film yield behaviour can adequately be described by setting an exponential decay of the sputtering yield, governed by the Gaussian sputtering depth amplitude.

We applied the model to swift ion irradiation experiments of solid N_2 . The sputtering yield dependence on the stopping power is evaluated in light of the measured high stopping power yield. The results obtained confirm that the sputtering yield evolve quadratically with the stopping power in solid N_2 . The discrepancy between sputtering yields previously measured at low stopping power is thus reduced, renewing the interest for additional N_2 ice measurements at low stopping power. Our model also determined the sputtering depth, showing that the sputtering crater left over by single ions possesses a large depth to radius aspect ratio for solid N_2 . It would be worth investigating the general behaviour of the crater topology with Se further with explicit 3D thermal spike models, especially for the molecular solids case such as ices.

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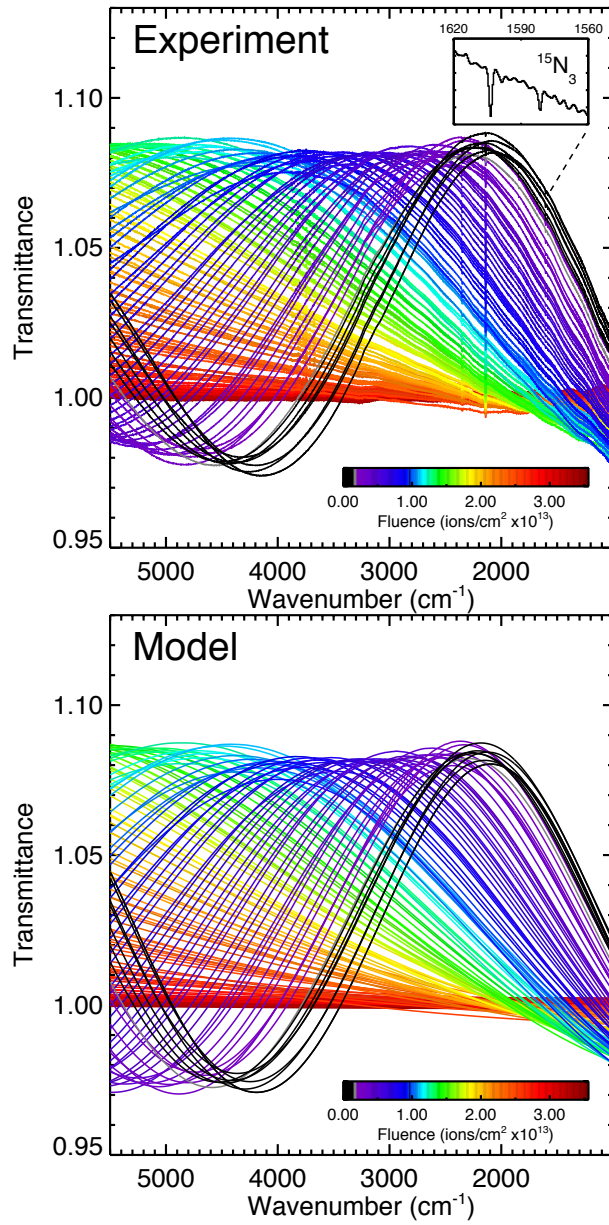


Figure 1: Upper panel: Infrared transmittance spectra of a $^{15}\text{N}_2$ ice film evolution as a function of $33\text{MeV } ^{58}\text{Ni}^{9+}$ ion fluence. The insert shows a zoom on the $^{15}\text{N}_3$ transitions arising as a doublet at 1603 and 1598 cm^{-1} . Lower Panel: Model spectra fitted to the data as a function of fluence. See text for model details.

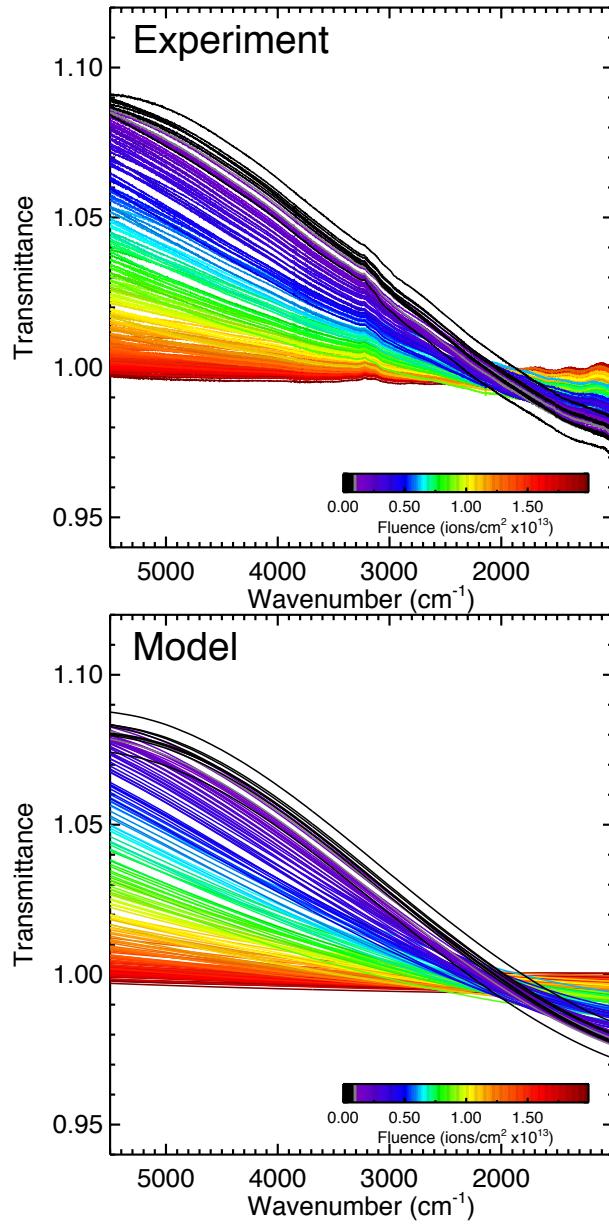


Figure 2: Upper panel: Infrared transmittance spectra of a thinner $^{15}\text{N}_2$ ice film evolution as a function of $33\text{MeV } ^{58}\text{Ni}^{9+}$ ion fluence. Lower Panel: Model spectra fitted to the data as a function of fluence. See text for model details.

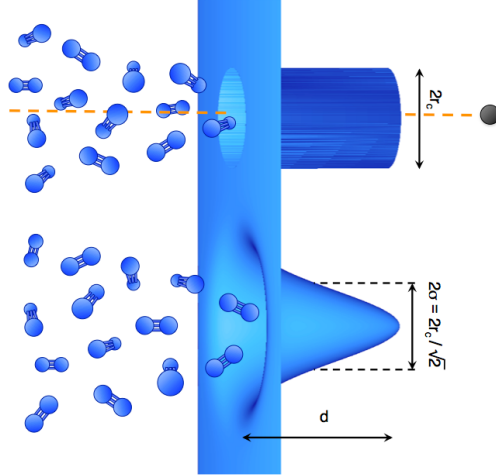


Figure 3: Schematic view of the sputtering crater models: a cylinder and 2D Gaussian. The parameters are defined with a common maximum depth d , for both shapes, and conserving the same volume.

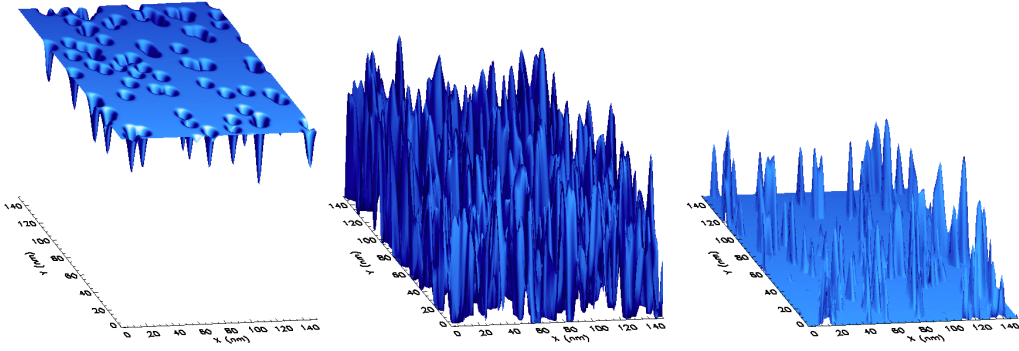


Figure 4: Snapshots of one realisation of the model with a Gaussian sputtering crater shape with an aspect ratio of 40, a depth corresponding to $N_D = 4 \times 10^{17} \text{ cm}^{-2}$, and an initial N_2 ice column density of $N_0 = 2 \times 10^{18} \text{ cm}^{-2}$. The left, middle, and right panels show the film topography when the column density decreased to $1.95 \times 10^{18} \text{ cm}^{-2}$, $5 \times 10^{17} \text{ cm}^{-2}$, and $2.5 \times 10^{16} \text{ cm}^{-2}$, respectively.

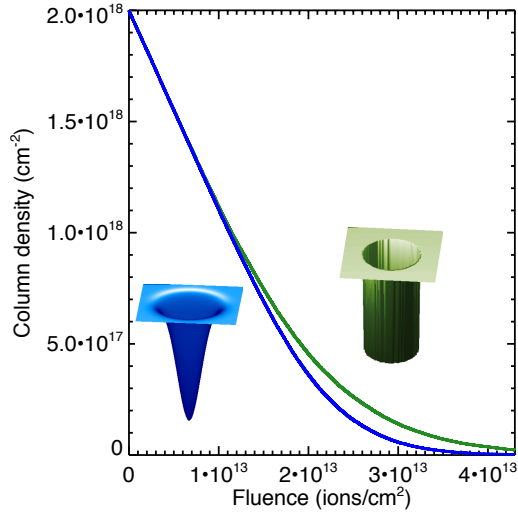


Figure 5: Comparison of 2D Gaussian (blue line, lowest curve) and cylinder (green line) crater shape on the expected column density evolution, for a model with the same sputtered volume, an aspect ratio of 40, a depth corresponding to $N_D = 4 \times 10^{17} \text{ cm}^{-2}$, and an initial N_2 ice column density of $N_0 = 2 \times 10^{18} \text{ cm}^{-2}$.

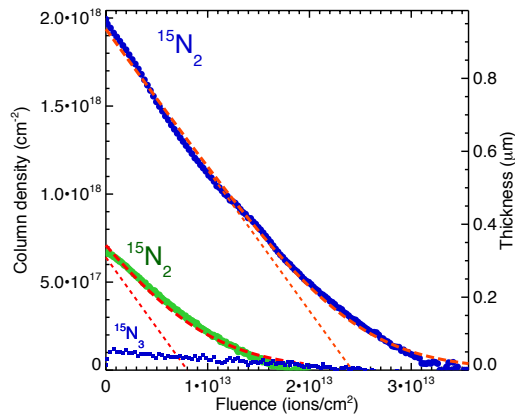


Figure 6: $^{15}\text{N}_2$ column density evolution as a function of fluence obtained from the spectra modeling fits (thick film, blue circles ;thin film, green circles). The right y-axis indicates the corresponding film thickness with the adopted density. The sputtering model for the thick film is overlaid in thick red dashed line. The expected thick film model without taking into account the finite thickness of the film is shown in thin dashed line. For the thin film, we cannot fit the model as the straight slope (semi-infinite sputtering yield) value is unconstrained. To show it behaves in the same way, the model retrieved from the thick film measurements was shifted in abscissa and overlaid. The $^{15}\text{N}_3$ column density evolution for the thick film measured via its doublet transition is shown with blue squares.

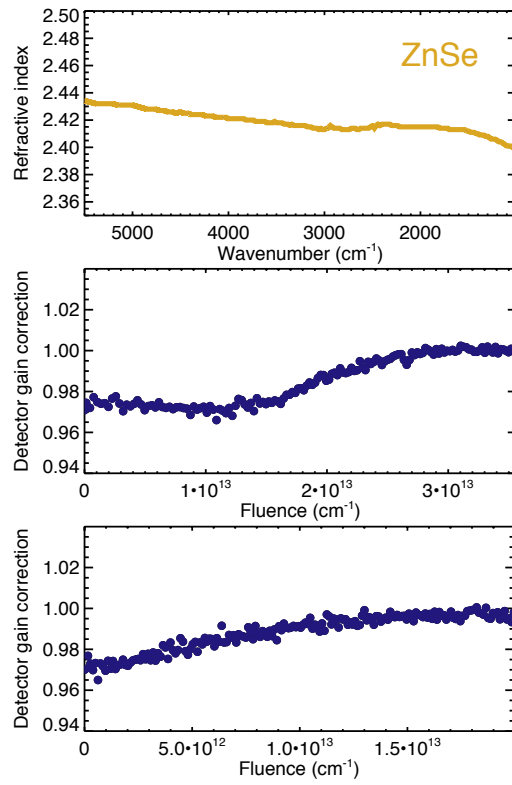


Figure 7: Upper panel: Refractive index of the ZnSe substrate used in the model calculation [15]. Middle panel: Small gain correction factor (typically $\lesssim 2\%$) applied to the spectra of the $^{15}\text{N}_2 \sim 1\mu\text{m}$ thick film and used in the modeling of the fringe pattern to retrieve the film thickness. Note that we clearly see the transition from the day to night experiment hall variations. Lower panel: Small gain correction factor (typically $\lesssim 2\%$) applied to the spectra of the $^{15}\text{N}_2 \sim 0.3\mu\text{m}$ thin film and used in the modeling of the fringe pattern to retrieve the film thickness.

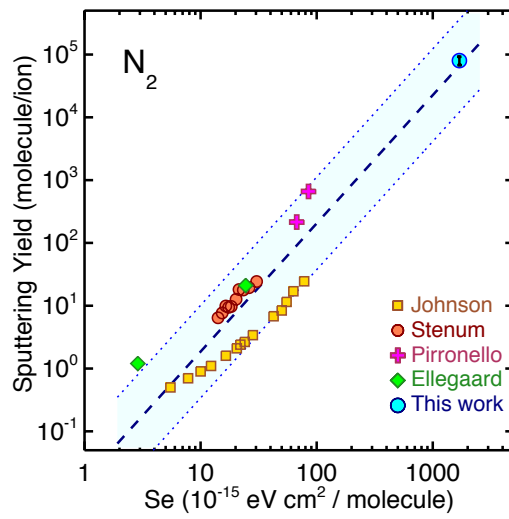


Figure 8: Solid N₂ sputtering yield in function of the stopping power, including measurements from the literature [10, 28, 29, 30]. The fitted evolution of the sputtering with the stopping power is shown with the blue dashed line. The error on the absolute scale of the evolution is shown with the filled light blue region.

Table 2: N₂ electronic sputtering experiments

T(K)	Ion	Energy (MeV)	Se ^(a)	Yield	Ref.
<10	H ⁺	<i>b</i>	14.1	6.4	<i>b</i>
<10	H ⁺	<i>b</i>	15.3	7.7	<i>b</i>
<10	H ⁺	<i>b</i>	16.5	9.9	<i>b</i>
<10	H ⁺	<i>b</i>	17.5	9.4	<i>b</i>
<10	H ⁺	<i>b</i>	18.4	9.7	<i>b</i>
<10	H ₂ ⁺	<i>b</i>	20.2	12.7	<i>b</i>
<10	H ₂ ⁺	<i>b</i>	23.3	17.8	<i>b</i>
<10	H ₂ ⁺	<i>b</i>	26.1	19.4	<i>b</i>
<10	H ₃ ⁺	<i>b</i>	21.4	18.1	<i>b</i>
<10	H ₃ ⁺	<i>b</i>	30.4	24.3	<i>b</i>
10	H ⁺	2.5	5.5	0.5	<i>c</i>
10	H ⁺	1.5	7.8	0.7	<i>c</i>
10	H ⁺	1.0	10	0.9	<i>c</i>
10	H ⁺	0.8	12.3	1.1	<i>c</i>
10	H ⁺	0.5	16.5	1.6	<i>c</i>
10	H ⁺	0.36	20.5	2.1	<i>c</i>
10	H ⁺	0.32	22	2.4	<i>c</i>
10	H ⁺	0.26	24	2.65	<i>c</i>
10	H ⁺	0.2	28.2	3.4	<i>c</i>
10	He ⁺	1.5	78	24.5	<i>c</i>
10	He ⁺	2	63	17	<i>c</i>
10	He ⁺	2.5	55	11.5	<i>c</i>
10	He ⁺	3	50	8.4	<i>c</i>
10	He ⁺	4	42.5	6.8	<i>c</i>
10	He ⁺	1	85.1	660	<i>d</i>
10	He ⁺	1.8	67.3	215	<i>d</i>
10	He ⁺	0.03	24.46	21	<i>e</i>
10	e ⁻	0.002	2.88	1.2	<i>e</i>
10	⁵⁸ Ni ⁹⁺	33	1697	8±1.2×10 ⁴	

^a in units of 10⁻¹⁵ eV cm²/N₂ ^b [28], beam used are in the 1.5-10 keV/u range, the yield and stopping powers are extracted from the authors Fig.1 and renormalised to be expressed per N₂ molecule. ^c [10, 31]; H⁺ data with a linear dependence of the yield in function of the (lower) stopping power are not included. ^d [29] ^e [30]; the sputtering by 2 keV electrons is also shown for comparison.